

SmartClass™ E1/Datacom

Service Installation and Maintenance Tester



Key Features

- Performs E1/Datacom service installation and maintenance in easy-to-use, lightweight, and rugged form-factor
- Significantly reduces field technician training with Smart AutoConfiguration (AutoConfig) feature
- Works with PC software—download results for report preparation
- Provides additional E1 and Datacom testing with available software options
- Includes Event Log and Histogram for troubleshooting
- Capable of bidirectional monitoring and troubleshooting via dual E1 ports
- Offers color graphical user interface (GUI) available in multiple languages
- Supports G.703 Codirectional, Contradirectional, and Centralized interface testing

Applications

E1

- Provides terminate, monitor, bridge, and local loopback modes
- Provides G.703—2 Mb/s testing
- Conducts 2 M (Bulk), n x 64 kb/s BERT
- Measures performance G.821, G.826, and M.2100
- Provides audio monitor (VF drop)
- Provides transmit frequency offset
- Performs VF level and frequency measurements, VF tone insert
- Measures E1 signal level measurement
- Provides ABCD/Sa monitoring
- Provides round-trip delay
- Offers alarms (defects) and errors (anomalies) insertion
- Pulse shape (optional)
- Jitter (optional)
- MFC-R2 (optional)

Datacom

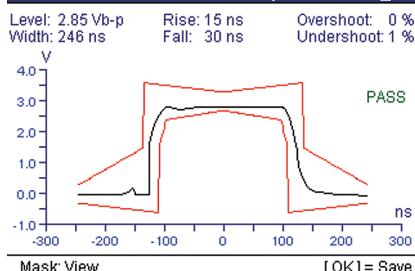
- Offers DTE emulate, DCE emulate, and monitor mode
- Interfaces with X.21, V.24 (RS232), V.35, V.36 (RS449), and EIA530
- Provides round-trip delay
- Frame Relay (optional)
- Conducts G.703 Codirectional, Contradirectional, and Centralized interface testing

Others

- Provides VT-100 terminal emulation (optional)
- Offers remote control (optional)

The JDSU SmartClass E1/Datacom is a handheld field tester for the installation and commissioning of E1 and Datacom service that offers multiple test modes for E1 and Datacom signal analysis. An economical and easy-to-use point solution, the SmartClass E1/Datacom has a Smart AutoConfiguration (AutoConfig) feature and large, easy-to-read color display that make the lightweight, rugged, battery-operated tester ideal for both service provider and contractor field technicians. It also meets the needs of mobile operators in the construction of E1 backhaul infrastructure.

2.2 Positive Pulse Shape



Pulse shape for extra E1 testing capability

Specifications

E1 Circuit Testing

Interfaces

Dual RJ48 ports (port 1 Rx/Tx, port 2 Rx only)
 120 balanced RJ48 (by default)
 120 balanced CF, 75 unbalanced BNC (via adapter cable)

Line Code AMI, HDB3

Tx Timing Internal
 Recovered

External (via adapter cable on Port 2)
 Tx Frequency Offset ±100 ppm in 1 ppm intervals

Framing Unframed, PCM31, PCM31C, PCM30, PCM30C

Test Mode Terminate, monitor, bridge, local loopback
 2M (Bulk), n x 64 kbps BERT

AutoConfig for framing and test pattern

LED Indicators SYNC, ALARM, ERROR, DATA, LPBK, BATT

Performance Monitoring

G.821, G.826, and M.2100

ABCD/Sa monitoring

Round-trip delay

Test Patterns

All ones, All zeros

1:1, 1:3 (1 in 4), 1:4 (1 in 5), 1:7 (1 in 8),

63 (2⁶-1), 511 (2⁹-1), 2047 (2¹¹-1), ITU INV2¹⁵⁻¹, ITU2¹⁵⁻¹, ITU INV2²⁰⁻¹,

ITU2²⁰⁻¹, ITU INV2²³⁻¹, ITU2²³⁻¹, QBF, QRSS, LIVE

User bit pattern (3 to 32 bits)

User byte pattern (1 to 64 bytes)

Key Results

Loss alarms, LOS seconds

Code error count, code error rate, timing slips, frame slips,

LOF alarms, LOF seconds, AIS alarms, AIS seconds, RDI alarms

RDI seconds, MF AIS alarms, MF AIS seconds, MF RDI alarms,

MF RDI seconds

FAS bit error count, FAS bit error rate, FAS word error count, MFAS

word error count, MFAS word error rate, CRC error Count, CRC error

rate, CRC sync loss count

FAS sync loss count, MFAS sync loss count, remote end block

error (E-Bit/REBE), NFAS word, MFAS word, NMFAS word

Si bit, A bit, Sa-bit sequence (Sa4—Sa8)

TSE/bit error count, TSE/bit error rate, block error count

pattern slips, pattern slip seconds

Pattern synchronization loss count, pattern synchronization

loss seconds, round trip delay (μs), elapsed time, time,

date/time-slot Rx byte, time-slot signaling data

Errors (Anomalies) Insert

2M code Single

2M FAS Single, 2, 3, 4

2M MFAS Single, 2

2M CRC Single

BERT pattern slip Single

E-Bit/REBE Single, Continuous

Bit (TSE) Single-rate 1e-2, 1e-3, 1e-4, 1e-5, 1e-6, 1e-7,

Multiple 1 to 50

Alarms (Defects) Insertion

LOS Continuous

Loss of frame (LOF) Continuous

AIS

RDI/FAS Dist

MF AIS

MF RDI/MFAS dist

VF Tests

VF level and frequency measurement

VF tone insert 404, 1004, 2713, 2804 Hz,
 -13.0, -3.0, 0.0, 3.0 dBm

VF drop to built-in speaker

Pulse Shape (optional)

Parameter Specification

Results Pulse shape graph

G.703 mask Pass/Fail

Pulse width resolution 2.75 ns

Rise time resolution 1 ns

Fall time resolution 1 ns

Undershoot resolution 1% of nominal level

Overshoot resolution 1% of nominal level

Signal level in [V] base-peak

Jitter (optional)

Test Modes Terminal, Monitor, Bridge

Jitter measurements available Manual Jitter Measurement

Maximum Tolerable Jitter Measurement (MTJ)

Fast Maximum Tolerable Jitter Measurement (FMTJ)

Jitter Transfer Measurement (JTF)

Manual Jitter Measurement

Rx accuracy 0.05UI or 3%, whichever is greater

Rx resolution 1/128UI

Range of Rx jitter amplitude (Ulipp) 10UI

Rx clock source Recovered clock

Tx accuracy 0.03UI or 3%, whichever is greater

Tx resolution 1/64UI

Tx frequency range (nominal) 20 Hz to 100 kHz

Range of Tx jitter amplitude (Ulipp) 0.1 to 10UI

Tx clock source Internal clock

Maximum Tolerable Jitter Measurement

Tx accuracy 0.03UI or 3%, whichever is greater

Tx resolution 1/64UI

Tx frequency points 20 Hz, 120 Hz, 1000 Hz, 2400 Hz, 6 kHz,

18 kHz, 30 kHz, 60 kHz, 100 kHz

Range of Tx jitter amplitude (Ulipp) 0.1 to 10UI

Results format Table and graphical

Fast Maximum Tolerable Jitter Measurement

Tx accuracy 0.03UI or 3%, whichever is greater

Tx resolution 1/64UI

Tx frequency points 20 Hz, 2400 Hz, 18 KHz, 60 kHz, 100 kHz

Range of Tx jitter amplitude (Ulipp) 0.1 to 1.5UI

Results format Table

Specifications

Jitter Transfer Measurement

Rx accuracy	0.05UI or 3%, whichever is greater	ANSI T1.617 Annex D, ITU-T Q.933 Annex A, LMI Rev 1, None
Rx resolution	1/128UI	DLCI 0 – 1023
Tx accuracy	0.03UI or 3%, whichever is greater	Link Trace Simple, Verbose, Text, Hex, Text, and Hex
Tx resolution	1/64UI	Long Frame 5 – 9999
Range of Tx jitter amplitude (Ulpp)	0.1 to 5UI	Load Test
Tx frequency points	20 Hz, 2400 Hz, 18 kHz, 60 kHz, 100 kHz	Test of CIR (load) Off, Fixed, Burst, Ping
Results format	Table and graphical	CIR Fixed Rate 1 – 10,000 kb/s
Intrinsic jitter of instrument	<0.07UI	Frame Lengths 5 – 9999
Results approximate to	ITU-T G.823 and 0.171	Payload Sequence, User 1, User 2, Sequence + User
MFC-R2 (optional)		Control Bits FECN, BECN, DE, C/R
Test Modes	Monitor, Simulate (Call in or out)	Burst Settings Tx time, Idle time
Country selection	ITU-T, Brazil, Mexico, India, China, Philippines, or User Defined	Ping
		Settings Source IP Address, Destination IP Address, Inverse ARP, Ping Length

Datacom Circuit Testing

Interfaces

X.21, V.24 (RS232), V.35, V.36 (RS449), and EIA530

via adapter cable

G.703 Codirectional, Contradirectional, and Centralized Interface testing via adapter cable

Data Rates (Emulate and Monitor)

X.21	Sync 50 bps to 10 Mbps
V.24 (RS232)	Async 50 bps to 128 kbps
V.24 (RS232)	Sync 50 bps to 128 kbps
V.35	Sync 50 bps to 2048 kbps
V.36 (RS449)	Sync 50 bps to 10 Mbps
EIA-530	Sync 50 bps to 10 Mbps

BERT Patterns

All Ones, All Zeros,

1:1, 1:3 (1 in 4), 1:4 (1 in 5), 1:7 (1 in 8), 3:1, 7:1, 63 (2^{6-1}), 511 (2^{9-1}), 2047 (2 $^{11-1}$), 2047R, 2047R INV, 2 $^{15-1}$ (ANSI, ITU), 2 $^{20-1}$ (ANSI, ITU), 2 $^{23-1}$ (ANSI, ITU), QRSS, QBF, Delay User Bit Pattern (3 to 32 bits)

User Byte Pattern (1 to 64 bytes)

Transmit Clock Sources

Internal ±3 ppm, 1 ppm per year aging

Interface

Signaling Lead Control

Emulate DTE

RTS, DTR, LL, RL

Emulate DCE

CTS, DSR, DCD, TMA

Monitor

Self Loop

Internal

External Cable Test

Result Categories

Summary, Clock, BERT, Data, Control Signal, G.821, Time

Frame Relay (optional)

Interface Datacom

Test Mode Terminate and Monitor (UNI-U, UNI-N, NNI)

Other Software Options

VT-100 (optional)

This option enables the instrument to emulate a VT-100 terminal and to connect to network device via instrument 9-pin RS232 interface.

Remote Control (optional)

Lets the user use command lines to control the tester via serial interface. Command guide is available with the option.

General Tester

Languages

English, French, German, Italian, Japanese, Korean, Portuguese, Russian, Simplified Chinese, and Spanish

Power

4 AA field-replaceable batteries (NiMH or Alkaline)

NiMH battery operating (at 25°C) under typical conditions provides up to 5 hours of continuous use for E1 application and 2 hours of continuous use for Datacom application

Supports sleep mode

AC line operation via external adapter

Charging time (at 25°C) under typical conditions for empty to full charge: with unit OFF up to 5 hours; with unit ON up to 7 hours

Permissible Ambient Temperature

Nominal range of use 0 to +50°C

Storage and transport -10 to +60°C

Humidity

Operating humidity 10 to 90%

Physical

Size (H x W x D) 230 x 120 x 50 mm

Weight, including batteries <1 kg (2 lb)

Display 320 x 240 color display

CE Marked

Ordering Information

Order Number	Description	Software Options
CSC-E1DC-P1	SmartClass E1 Datacom Package (No software options included)	CSC-E1-PS Pulse Shape
CSC-E1DC-P2	SmartClass E1 Datacom Pulse Shape and Frame Relay Package (Pulse Shape and Frame Relay software option included)	CSC-E1-JIT Jitter
CSC-E1DC-P3	SmartClass E1 Datacom Premium Package (Pulse Shape, MFC-R2, Frame Relay, and VT-100 software option included)	CSC-E1-SIG MFC-R2
CSC-E1DC-P4	SmartClass E1 Datacom Pulse Shape and Jitter Package (Pulse Shape and Jitter software option included)	CSC-E1-FR Frame Relay
CSC-E1DC-P5	SmartClass E1 Datacom Complete Package (Pulse Shape, Jitter, MFC-R2, Frame Relay, and VT-100 software option included)	CSC-E1-VT100 VT-100
Accessories included with any package		CSC-E1-RC Remote Control
AC power adapter with plug kit (USA, UK, Australia, Europe)		
4 x AA NiMH batteries		
CD-ROM (including PC utility, USB driver, and User Guide)		
1 x RJ48-to-RJ48 cable		
1 x USB cable		
Small carrying bag		
Miscellaneous		
CC-120101	Large Carrying Bag	
AC-009801	Large Strand Hook	
SCACARCHARGER	Car Adapter Charging Kit	
ML-21107607	Printed User Manual SC E1 (English)	
ML-21121114	Printed SC E1 Remote Control Reference Guide (English)	
E1 Cables		
K1597	RJ48 to CF Y cable (120 W balanced)	
CB-44995	RJ48 to Dual BNC cable (75 W unbalanced)	
CB-0045402	2M External Clock Reference cable	
Datacom Cables		
CB-44391	X.21 10M DTE/DCE Emulate (Support up to 10 Mb/s)	
CB-44346	X.21 Monitor	
CB-44385	V.24 DTE/DCE Emulate	
CB-44348	V.24 Monitor	
CB-44389	V.35 DTE/DCE Emulate	
CB-44341	V.35 Monitor	
CB-44388	V.36 DTE/DCE Emulate	
CB-44347	V.36 Monitor	
CB-21118474	68-pin MDR to Bananas	
CB-21128081	68-pin MDR to DB15 (CB-2118474 and CB-21128081 for G.703 Codirectional, Contradirectional, and Centralized interface testing)	

Test & Measurement Regional Sales

NORTH AMERICA TEL: 1 866 228 3762 FAX: +1 301 353 9216	LATIN AMERICA TEL: +1 954 688 5660 FAX: +1 954 345 4668	ASIA PACIFIC TEL: +852 2892 0990 FAX: +852 2892 0770	EMEA TEL: +49 7121 86 2222 FAX: +49 7121 86 1222	WEBSITE: www.jdsu.com/test
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